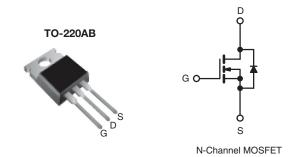


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	1000			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 5.0			
Q _g (Max.) (nC)	80			
Q _{gs} (nC)	10			
Q _{gd} (nC)	42			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRFBG30PbF		
Leau (FD)-iree	SiHFBG30-E3		
SnPb	IRFBG30		
SHED	SiHFBG30		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	1000		
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		3.1	А	
Continuous Drain Gurrent	V _{GS} at 10 V	T _C = 100 °C	ID	2.0		
Pulsed Drain Current ^a			I _{DM}	12		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	280	mJ	
Repetitive Avalanche Current ^a			I _{AR}	3.1	Α	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	1.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	7	
Mounting Toyaus	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 55 mH, R_g = 25 Ω , I_{AS} = 3.1 A (see fig. 12).
- c. $I_{SD} \le 3.1$ A, $dI/dt \le 80$ A/ μ s, $V_{DD} \le 600$, $T_{J} \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		1000	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		1.4	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Vo	V _{GS} = ± 20 V		-	± 100	nA
Zero Onto Welling a Burin On ordi	,	V _{DS} = 1000 V, V _{GS} = 0 V		-	-	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 800 V, V	V _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.9 A ^b	-	-	5.0	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 1	10 V, I _D = 1.9 A ^b	2.1	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V	$V_{GS} = 0 V$,		980	-	
Output Capacitance	C _{oss}	V	_{DS} = 25 V,	-	140	-	pF
Reverse Transfer Capacitance	C_{rss}	f = 1.0	MHz, see fig. 5	-	50	-	
Total Gate Charge	Q_g	1 01 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		-	-	80	
Gate-Source Charge	Q_{gs}	$V_{GS} = 10 \text{ V}$	$I_D = 3.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b	-	-	10	nC
Gate-Drain Charge	Q_{gd}		see lig. 6 and 15	-	-	42	
Turn-On Delay Time	t _{d(on)}	$V_{DD}=500~V,~I_D=3.1~A$ $R_g=12~\Omega,~R_D=170~\Omega,~see~fig.~10^b$		-	12	-	- ns
Rise Time	t _r			-	25	-	
Turn-Off Delay Time	t _{d(off)}			-	89	-	
Fall Time	t _f			-	29	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		=	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.1	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	12	,,
Body Diode Voltage	V_{SD}	T _J = 25 °C, I	$T_J = 25 ^{\circ}\text{C}, I_S = 3.1 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.1 A, dl/dt = 100 A/μs ^b		-	410	620	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.3	2.0	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	-on is do	minated b	ov I c and	12)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

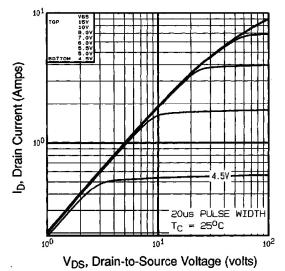


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

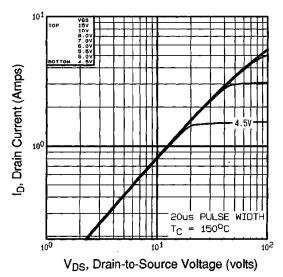


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

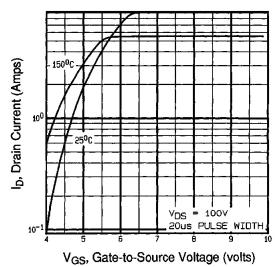


Fig. 3 - Typical Transfer Characteristics

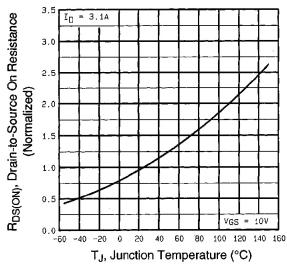


Fig. 4 - Normalized On-Resistance vs. Temperature



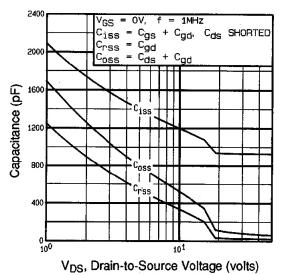


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

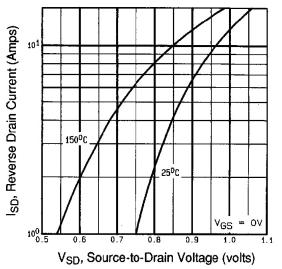


Fig. 7 - Typical Source-Drain Diode Forward Voltage

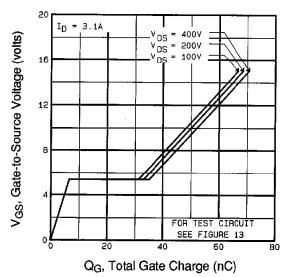


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

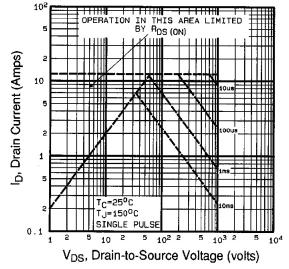


Fig. 8 - Maximum Safe Operating Area





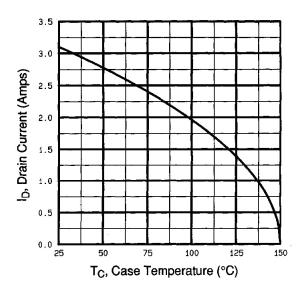


Fig. 9 - Maximum Drain Current vs. Case Temperature

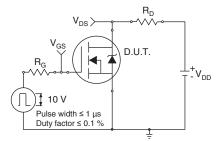


Fig. 10a - Switching Time Test Circuit

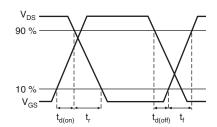


Fig. 10b - Switching Time Waveforms

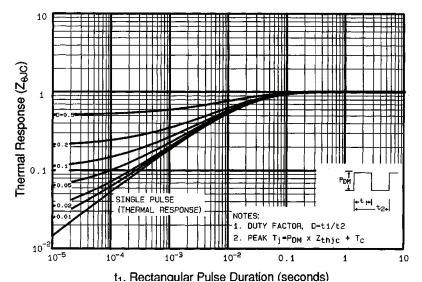


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



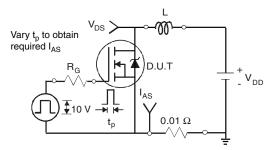


Fig. 12a - Unclamped Inductive Test Circuit

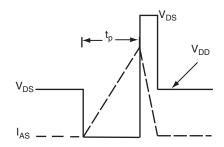


Fig. 12b - Unclamped Inductive Waveforms

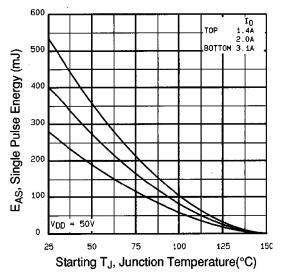


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

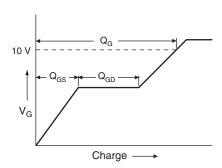


Fig. 13a - Basic Gate Charge Waveform

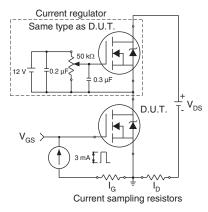
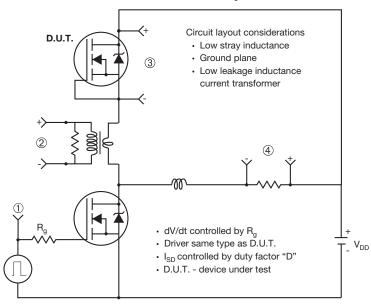


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



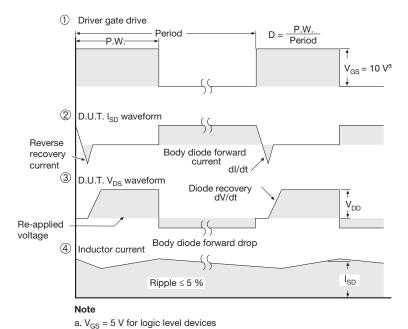


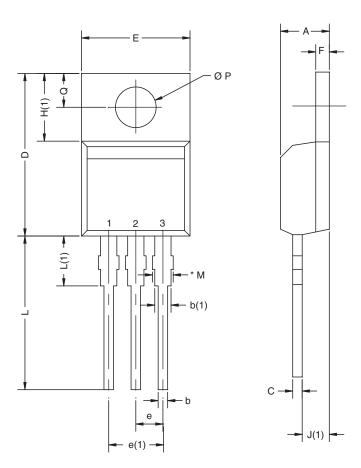
Fig. 14 - For N-Channel

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TO-220AB



	MILLIN	METERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X10-0416-Rev. M, 01-Nov-10					

DWG: 5471

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM





Vishay

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